

FMOS10130A-Q1

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FMOS10130A-Q1

3A 100V N-Channel Advanced Mode Power MOSFET

Features

- $V_{DS} = 100V$, $I_D = 3A$.
- $R_{DS(ON)} \leq 130m\Omega$, @ $V_{GS}=10V$, $I_D=3A$.
- $R_{DS(ON)} \leq 190m\Omega$, @ $V_{GS}=4.5V$, $I_D=1A$.
- Advanced split gate trench technology.
- Excellent $R_{DS(ON)}$ and low gate charge.
- Qualified to AEC-Q101 standards for high reliability.
- Lead-free parts meet RoHS requirements.
- Suffix "-H" indicates Halogen-free part, ex. FMOS10130A-Q1-H.

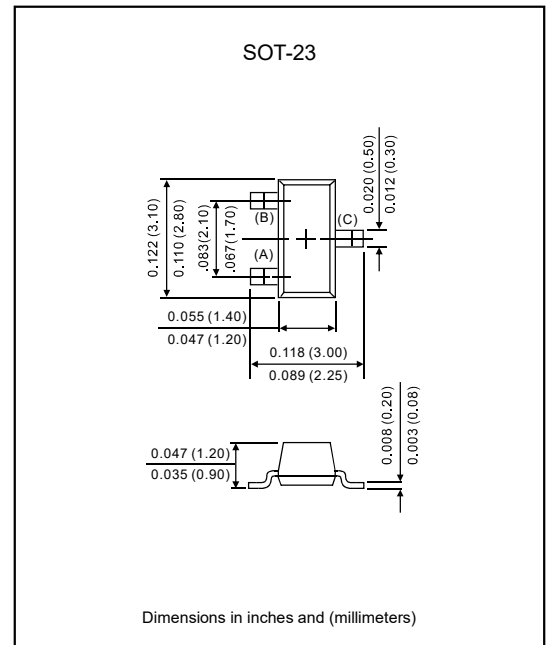
Applications

- DC/DC converter.
- LED backlighting.
- Motor control.

Mechanical data

- Epoxy:UL94-V0 rated flame retardant.
- Case : Molded plastic, SOT-23.
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026.

Package outline



Maximum ratings ($T_c=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Rated	Unit
Drain-source voltage	V_{DS}	100	V
Gate-source voltage	V_{GS}	± 20	V
Continuous drain current ($T_c=25^\circ C$) ($T_c=100^\circ C$)	I_D	3	A
		2.2	
Pulsed drain current (Note 1)	I_{DM}	12	A
Single pulsed avalanche energy (Note 2)	E_{AS}	7.2	mJ
Power dissipation	P_D	3.1	W
Thermal resistance form junction to ambient (Note 3)	$R_{\theta JA}$	40.3	$^\circ C/W$
Operating Junction temperature	T_j	+150	$^\circ C$
Storage temperature range	T_{STG}	-55 to +150	$^\circ C$

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Electrical characteristics (At $T_j=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off characteristics						
Drain-source breakdown voltage	BV_{DSS}	$I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$	100			V
Drain-source leakage current	I_{DSS}	$V_{DS}=100\text{V}$, $V_{GS}=0\text{V}$			1	μA
Gate-source leakage current	I_{GSS}	$V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$			± 100	nA

On characteristics

Gate threshold voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	1.0	1.65	2.5	V
Static drain-source on-resistance (Note 4)	$R_{DS(ON)}$	$V_{GS}=10\text{V}$, $I_D=3\text{A}$		95	130	m Ω
		$V_{GS}=4.5\text{V}$, $I_D=1\text{A}$		135	190	

Dynamic Parameters

Input capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=50\text{V}$, $f=1.0\text{MHz}$		200		pF
Output capacitance	C_{oss}			30		
Reverse transfer capacitance	C_{rss}			3		
Total gate charge	Q_g	$V_{GS}=0$ to 10V , $V_{DS}=50\text{V}$, $I_D=3\text{A}$		4		nC
Gate to source charge	Q_{gs}			0.9		
Gate to Drain charge	Q_{gd}			1.1		

Switching parameters

Turn-on delay time	$t_{d(on)}$	$V_{GS}=10\text{V}$, $V_{DS}=50\text{V}$, $I_D=3\text{A}$, $R_G=3\Omega$		13		ns
Turn-on rise time	t_r			19		
Turn-off delay time	$t_{d(off)}$			20		
Turn-off fall time	t_f			28		

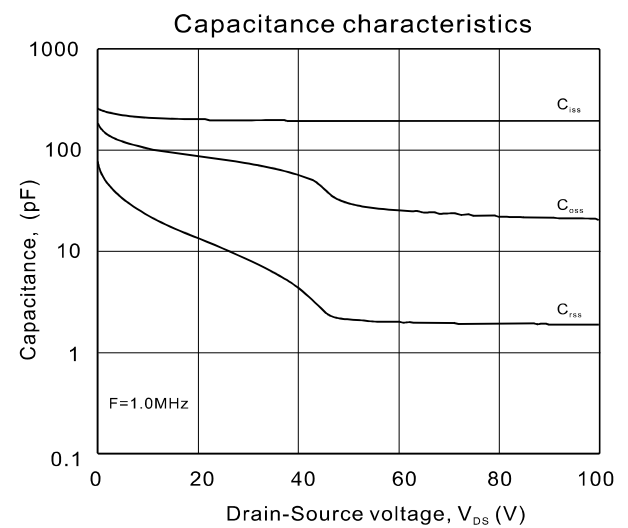
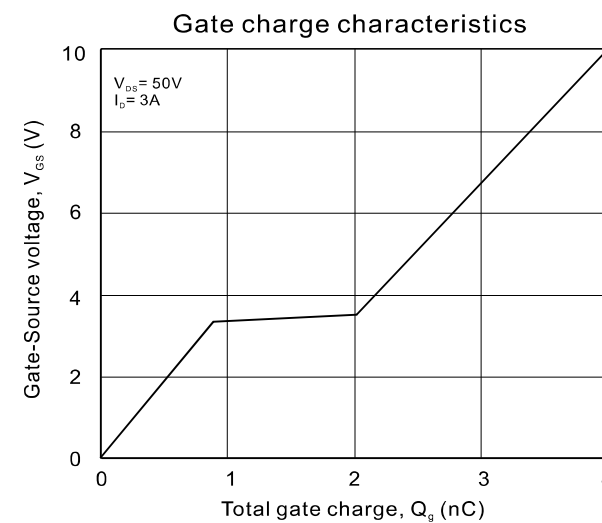
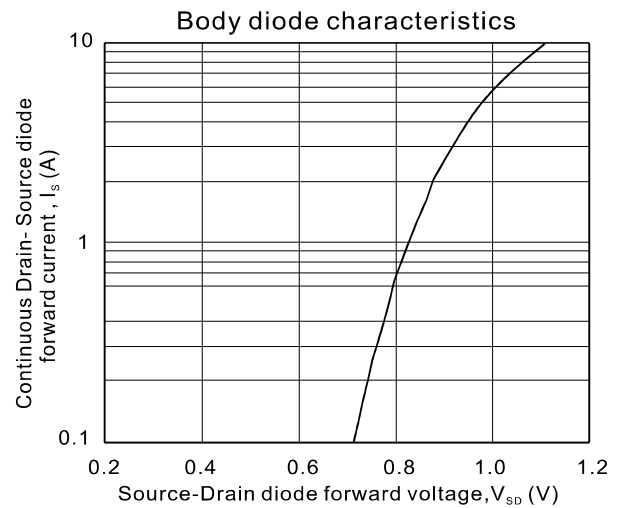
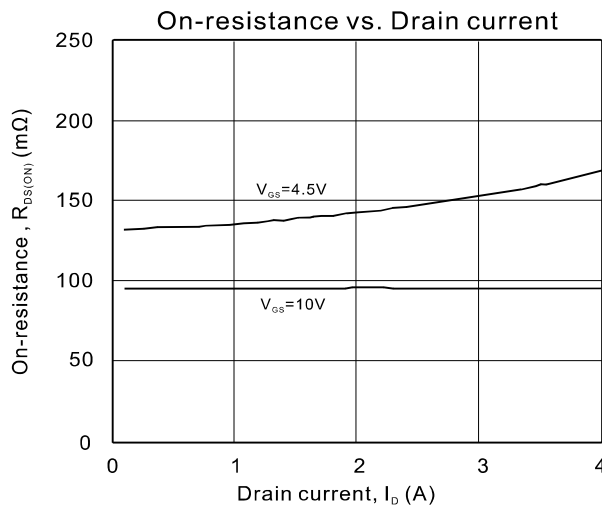
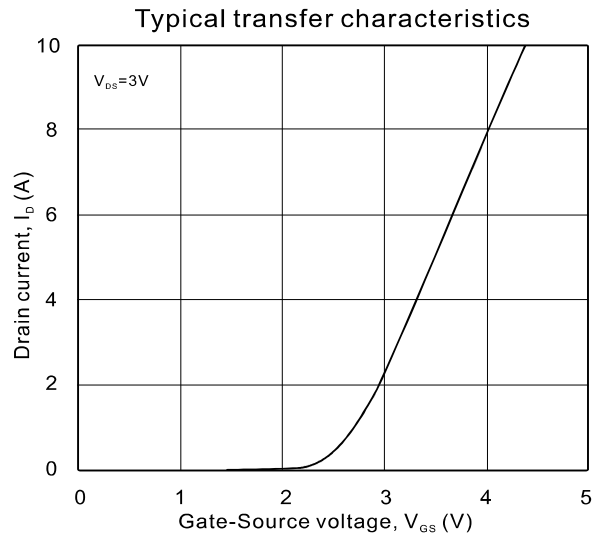
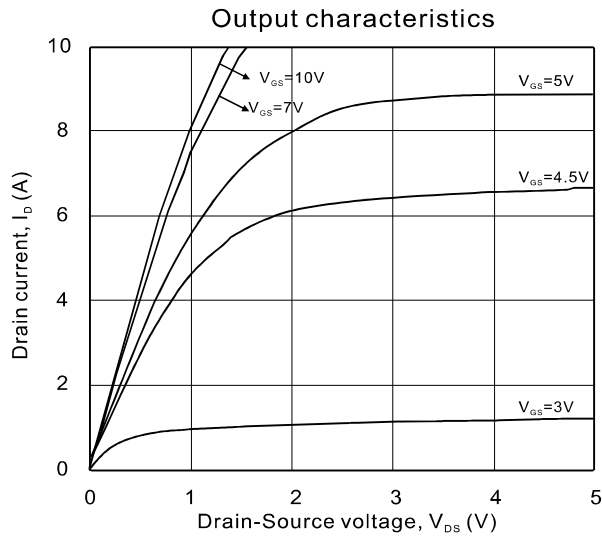
Source-drain diode ratings and characteristics

Maximum continuous Drain- Source diode forward current	I_S				3	A
Maximum pulsed Drain- Source diode forward current	I_{SM}				12	
Drain - source diode forward voltage	V_{SD}	$V_{GS}=0\text{V}$, $I_S=3\text{A}$			1.2	V

- Note : 1. Repetitive rating : pulse width limited by maximum junction temperature.
 2. $R_{\theta(jc)}$ is measured with the device mounted on a 1 inch² pad of 2oz copper FR4 PCB.
 3. Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 0.5\%$.

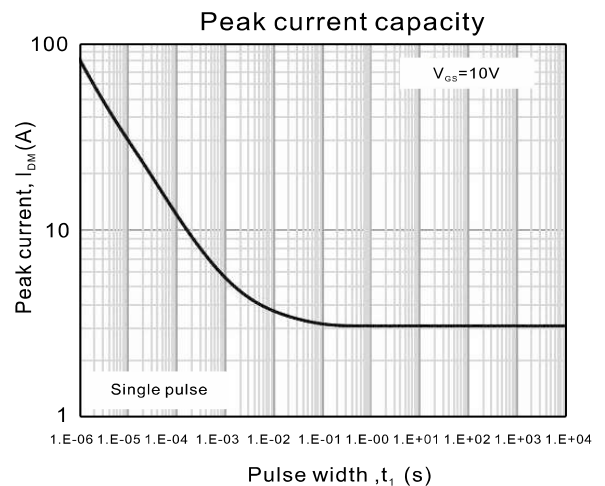
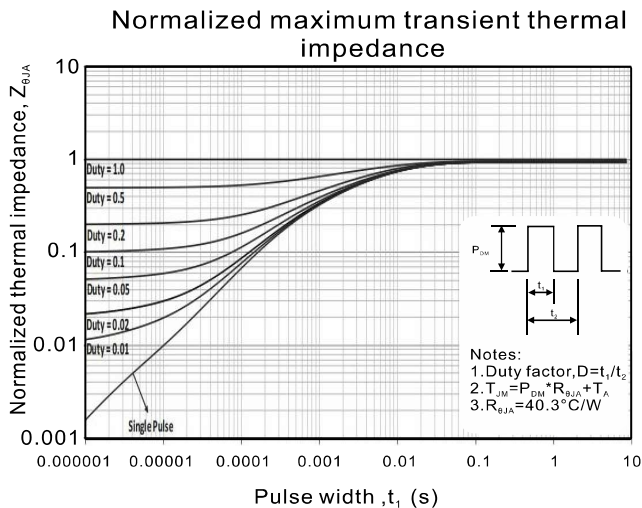
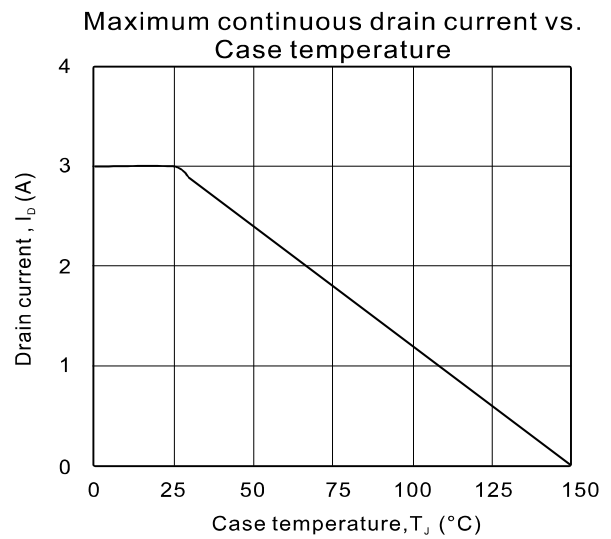
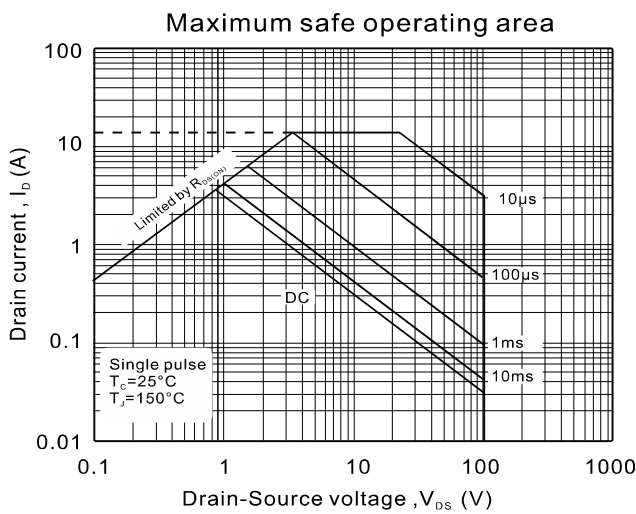
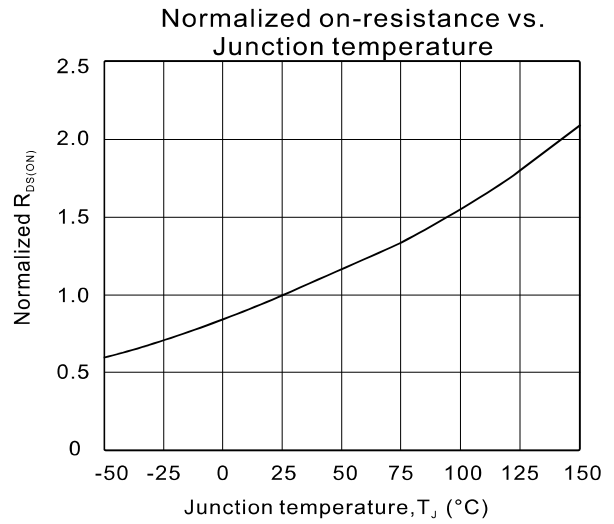
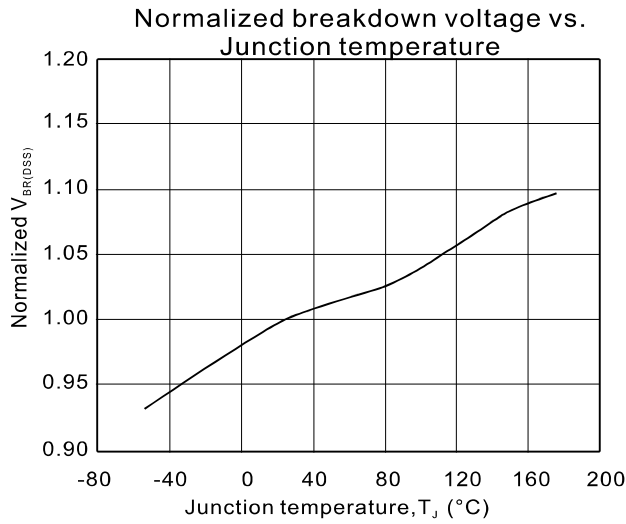
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Rating and characteristic curves



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Rating and characteristic curves



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Pinning information

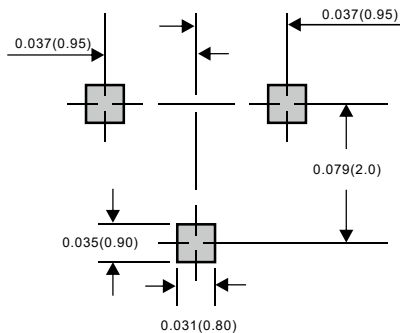
Pin	Simplified outline	Symbol
Pin 1 Gate Pin 2 Source Pin 3 Drain		

Marking

Type number	Marking code
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Suggested solder pad layout

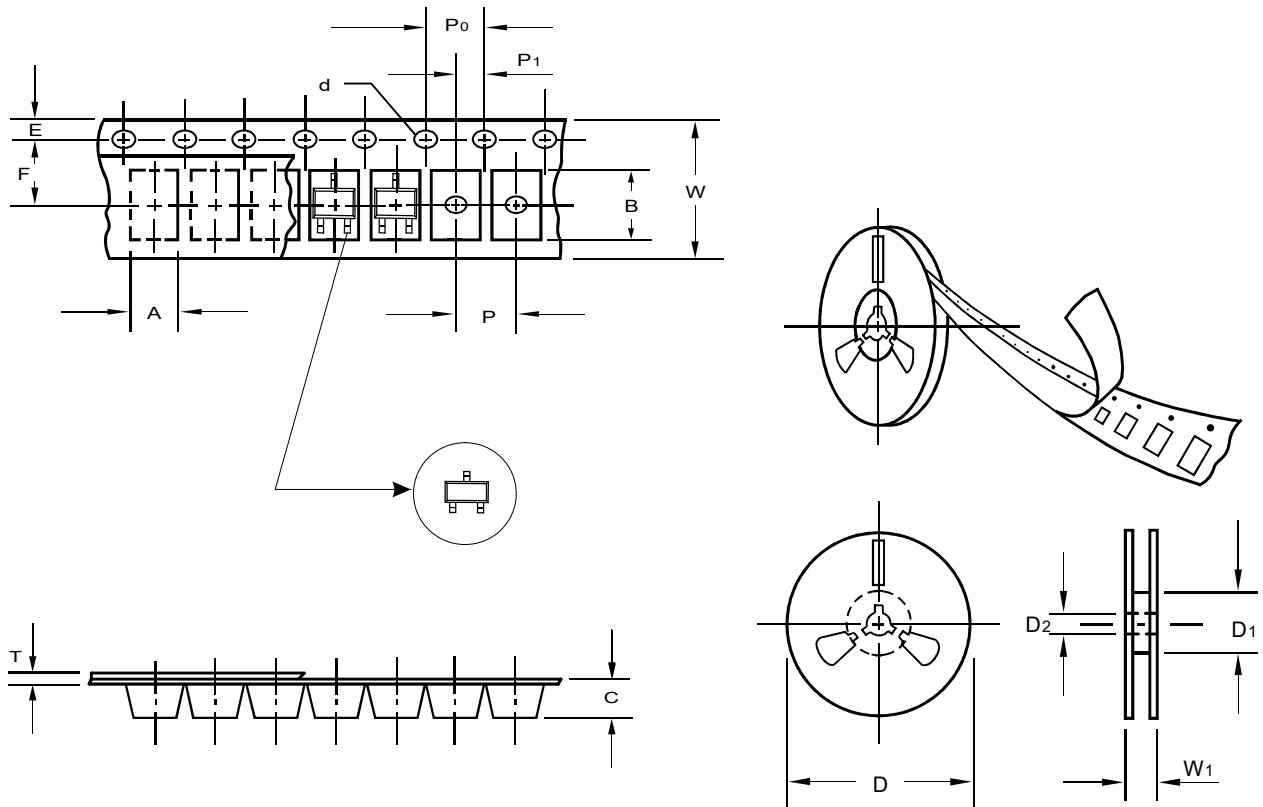
SOT-23



Dimensions in inches and (millimeters)

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Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	54.40
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	11.40

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

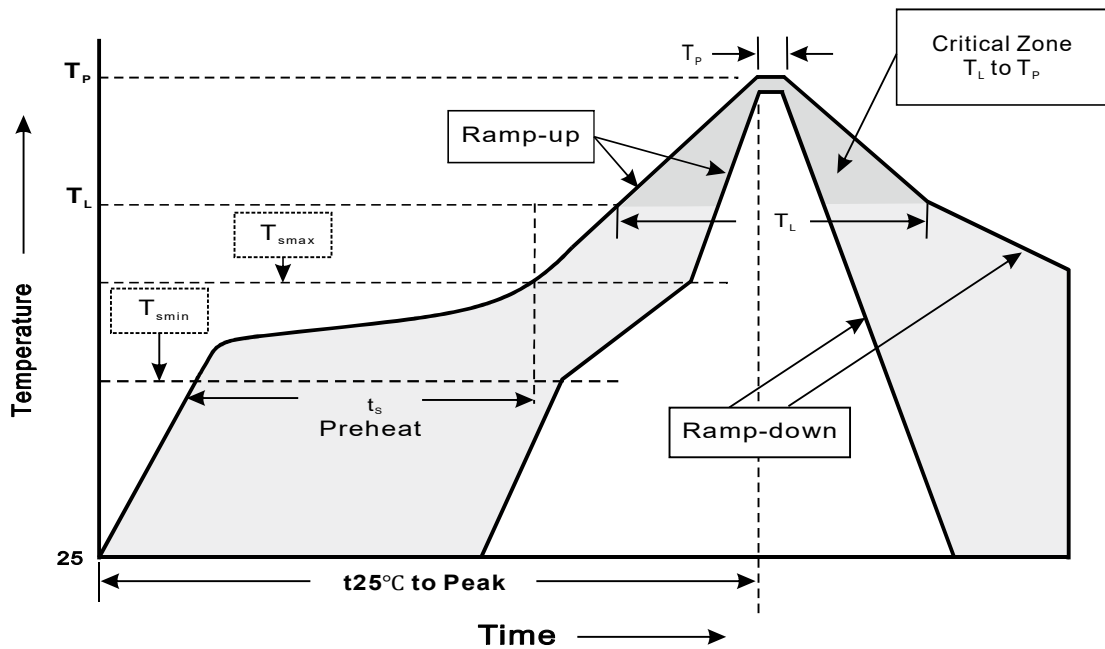
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Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)
SOT-23	7"	3,000	4.0	30,000	183*123*183	178	382*257*387	240,000

Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
- 2.Reflow soldering of surface-mount devices



3.Reflow soldering

Profile feature	Soldering Condition
Average ramp-up rate (T_L to T_p)	< 3°C/sec
Preheat -Temperature Min (T_{smin}) -Temperature Max (T_{smax}) -Time (min to max) (t_s)	150°C 200°C 60 ~ 120sec
T_{smax} to T_L -Ramp-up rate	< 3°C/sec
Time maintained above: -Temperature (T_L) -Time(T_L)	217°C 60 ~ 260 sec
Peak Temperature(T_p)	255°C -0/+5°C
Time within 5°C of actual peak Temperature(T_p)	10 ~ 30sec
Ramp-down rate	< 6°C/sec
Time 25°C to peak temperature	< 6 minutes